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### Dual Notebook Power Supply N-Channel PowerTrench<sup>®</sup> SyncFET<sup>™</sup>

### **General Description**

The FDS6984S is designed to replace two single SO-8 MOSFETs and Schottky diode in synchronous DC:DC power supplies that provide various peripheral voltages for notebook computers and other battery powered electronic devices. FDS6984S contains two unique 30V, N-channel, logic level, PowerTrench MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the low-side switch (Q2) is optimized to reduce conduction losses. Q2 also includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology.

### Features

• Q2: Optimized to minimize conduction losses Includes SyncFET Schottky diode

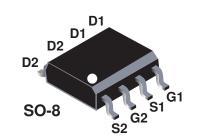
8.5A, 30V  $R_{DS(on)} = 19 \text{ m}\Omega @ V_{GS} = 10V$ 

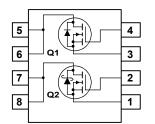
 $R_{DS(on)}$  = 28 m $\Omega$  @  $V_{GS}$  = 4.5V

• Q1: Optimized for low switching losses Low gate charge ( 5 nC typical)

5.5A, 30V  $R_{DS(on)} = 0.040\Omega @ V_{GS} = 10V$ 

 $R_{DS(on)} = 0.055\Omega @ V_{GS} = 4.5V$ 





### **Absolute Maximum Ratings** $T_{A} = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter			Q2	Q1	Units
V <sub>DSS</sub>	Drain-Source	Voltage		30	30	V
V <sub>GSS</sub>	Gate-Source	Voltage		±20	±20	V
ID	Drain Current	- Continuous	(Note 1a)	8.5	5.5	A
		- Pulsed		30	20	
PD	Power Dissipation for Dual Operation			:	W	
	Power Dissipation for Single Operation (Note 1a)			1		
			(Note 1b)		1	
			(Note 1c)	0	.9	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 tc	°C	
Therma	I Charact	eristics				
R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient (Note 1a)			7	°C/W	
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case (Note 1)			4	°C/W	
Packag	e Marking	and Ordering Ir	nformation			
Device Marking		Device	Reel Size	Tape width		Quantity
FDS6984S		FDS6984S	13"	12mm	1	2500 units

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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA	Q2	30			V
	Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V	Q1	30			
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$	Q2 Q1			500 1	μA
GSSF	Gate-Body Leakage, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V	All			100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS}$ = -20 V, $V_{DS}$ = 0 V	All			-100	nA
On Char	acteristics (Note 2)						•
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 1 \text{ mA}$	Q2	1		3	V
$\Delta V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$ $I_D = 1 \ mA$ , Referenced to 25°C	Q1 Q2	1	-6	3	mV/°C
$\Delta V GS(th)$ $\Delta T_{J}$	Temperature Coefficient						mv/°C
-		I <sub>D</sub> = 250 uA, Referenced to 25°C	Q1		-4		
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.5 A V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8.5 A, T <sub>J</sub> = 125°C	Q2		16 24	19 32	mΩ
	On-Resistance	$V_{GS} = 10$ V, $I_D = 8.5$ A, $I_J = 125^{\circ}$ C $V_{GS} = 4.5$ V, $I_D = 7$ A			24	28	
		$V_{GS}$ = 4.5 V, $I_D$ = 7 A $V_{GS}$ = 10 V, $I_D$ = 5.5 A	Q1		35	40	
		$V_{GS} = 10 \text{ V}, \text{ I}_D = 5.5 \text{ A}, \text{ T}_J = 125^{\circ}\text{C}$			53 48	60 55	
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS}$ = 4.5 V, $I_D$ = 4.6 A $V_{GS}$ = 10 V, $V_{DS}$ = 5 V	Q2	30	40	55	A
·D(01)			Q1	20			
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 8.5 A V <sub>DS</sub> = 5 V, I <sub>D</sub> = 5.5 A	Q2 Q1		26 40		S
Dynami	c Characteristics	VDS - 3 V, ID - 3.3 A			40		
	Input Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V,	Q2		1233		pF
		f = 1.0 MHz	Q1		462		P -
Coss	Output Capacitance		Q2 Q1		344 113		pF
C <sub>rss</sub>	Reverse Transfer Capacitance		Q1 Q2		106		pF
			Q1		40		
Switchir	g Characteristics (Note 2					-	
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A},$	Q2		8 10	16	ns
t,	Turn-On Rise Time	$V_{GS}$ = 10V, $R_{GEN}$ = 6 $\Omega$	Q1 Q2		5	18 10	ns
-1			Q1		14	25	
t <sub>d(off)</sub>	Turn-Off Delay Time		Q2 Q1		25 21	40 34	ns
t <sub>f</sub>	Turn-Off Fall Time	-	Q1 Q2		11	20	ns
			Q1		7	14	
Qg	Total Gate Charge	Q2 V <sub>DS</sub> = 15 V, I <sub>D</sub> = 8.5 A, V <sub>GS</sub> =5V	Q2 Q1		11 8.5	16 12	nC
Q <sub>gs</sub>	Gate-Source Charge		Q2		5	12	nC
-	Osta Dasia Oh	Q1 V <sub>DS</sub> = 15 V, I <sub>D</sub> = 5.5 A, V <sub>GS</sub> = 5 V	Q1		2.4		
$Q_{gd}$	Gate-Drain Charge	$v_{DS} - 15 v, i_D - 5.5 A, v_{GS} = 5 V$	Q2 Q1		4 3.1		nC

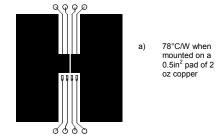
FDS6680S Rev C (W)

Symbol	Parameter	Test Conditions		Туре	Min	Тур	Max	Units
Drain-S	ource Diode Characteris	stics and Maximum Rat	tings					
ls	Maximum Continuous Drain-Source Diode Forward Current			Q2 Q1			3.0 1.3	A
trr	Reverse Recovery Time	I <sub>F</sub> = 10A,		Q2		17		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A}/\mu \text{s}$ (Note	e 3)			12.5		nC
$V_{\text{SD}}$	Drain-Source Diode Forward Voltage		(Note 2) (Note 2)	Q2 Q1		0.5 0.74	0.7 1.2	V

Notes:

1. R<sub>8JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.

b)





125°C/W when mounted on a 0.02 in<sup>2</sup> pad of 2 oz copper

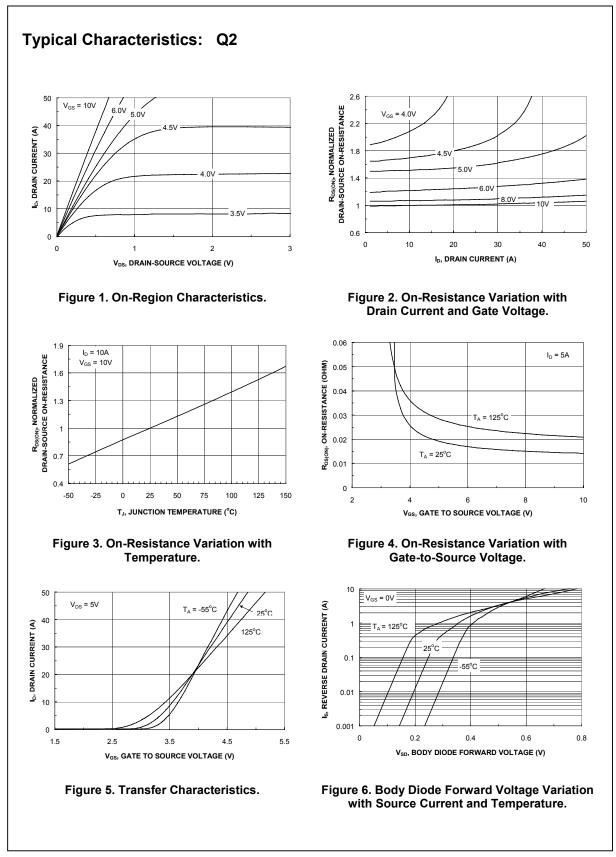
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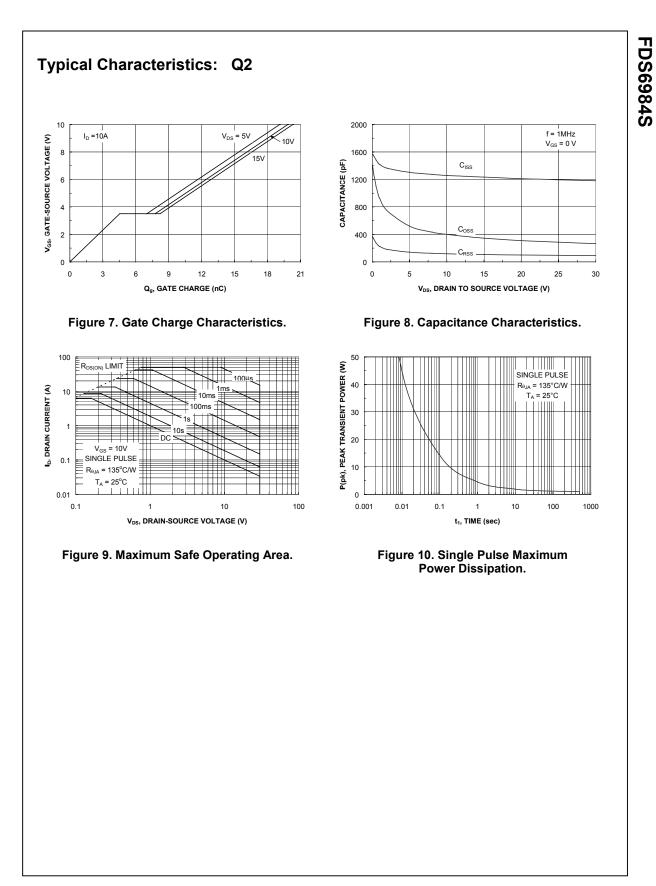
135°C/W when mounted on a c) minimum pad.

Scale 1 : 1 on letter size paper

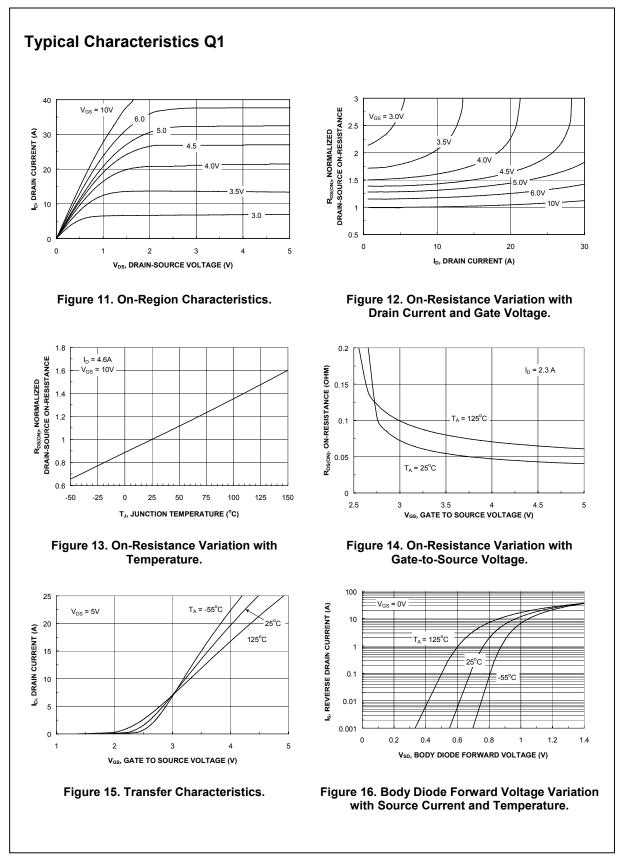
See "SyncFET Schottky body diode characteristics" below.
Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%</li>

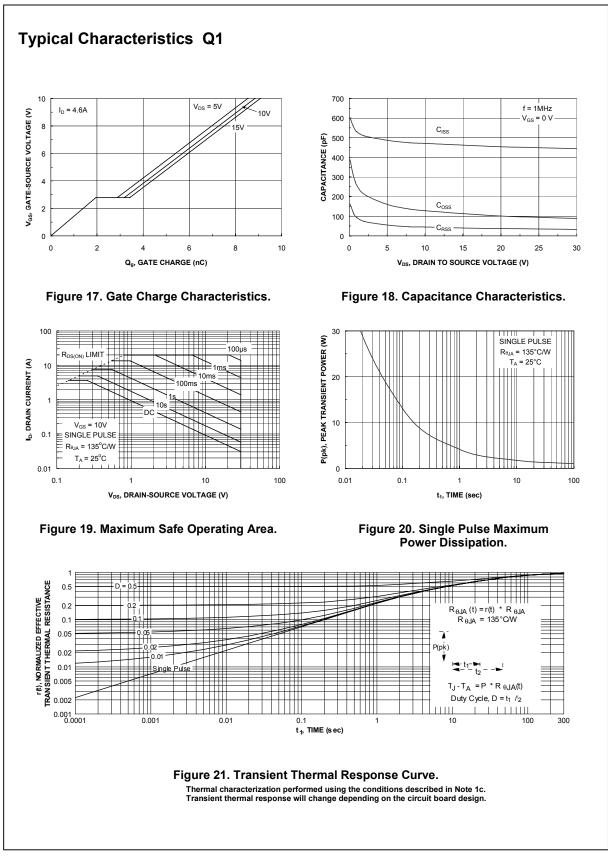
FDS6680S Rev C (W)





FDS6680S Rev C (W)

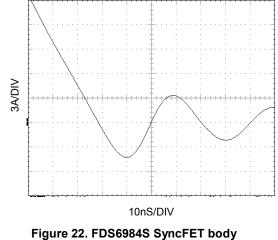




### Typical Characteristics (continued)

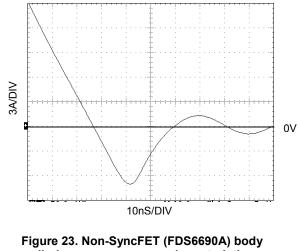
## SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 22 shows the reverse recovery characteristic of the FDS6984S.



diode reverse recovery characteristic.

For comparison purposes, Figure 23 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6690A).



diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

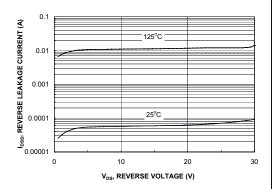


Figure 24. SyncFET body diode reverse leakage versus drain-source voltage and temperature.



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